## ■ Cutting the data cake — having your cake and sampling it -(a)

Tony Davies (Chemometrics Column Editor)

This month I want to tackle one of the most crucial concepts of chemometrics. The proposition is: the way in which data was collected may not be the best form for analysing it.

Many chemists and some spectroscopists find this difficult but it is essential that we overcome our inhibitions of only regarding data from this conventional point of view. This article will try to present a pictorial view of data manipulations which I hope will be helpful. If Professor Stephen Hawking prefers pictures to mathematics, 1 I don't see why anyone should be embarrassed about using a "naive" approach.

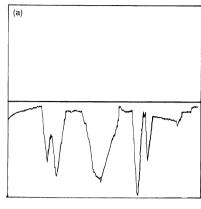
Figure 1 is our data cake. It is a layer cake; each layer being a spectrum. For example in our cake the x axis is the wavenumber (or wavelength) data, the y axis is the sample number and the z axis is the transmission (or absorption) data.

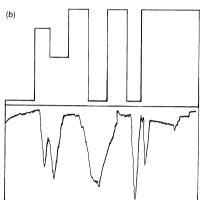
If we have a rectangular cake the social custom is to offer slices cut at right angles to the longest slice. This is the same for our data cake because such a slice would compare the transmission for each sample at the same wavenumber — the customary way of analysing spectroscopic data. In a simple case, where there was a

direct relationship between the sample number and its transmission at a particular wavelength, our slice would be a useful graph, as shown in Figure 1.

Figure 2 indicates how we could obtain two imaginary slices of cake. If we averaged the data in the y direction, this would be the average spectrum for the data set. We can also average, or just sum, the data in the x direction; this would represent the total transmission of each sample over the wavenumber range. We would not expect such data to be very interesting but I want you to remember that it is an option.

Now I want to cut a different cake. I need to introduce the idea of a graphic scaling factor. This is shown in Figure 3(a); the idea is that the top half of the graph represents a scaling factor between 0.0 and 1.0. If we cut a slice off the scaling factor in the x direction and then re-calculate the spectrum, the whole spectrum would be reduced by the same factor. Instead of a knife we could use a cutter to remove part of the scaling factor, as shown in Figure 3(b). When the spectrum is recalculated the product would be a modified spectrum as shown in Figure 3(c); some peaks have been





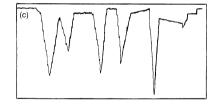


Figure 3. Graphic scaling factor.

enhanced while others have been removed. We will now transfer the idea to the cake.

cake; reminiscent of a "Battenburgh". In Figure 4(b) the scaling factor has been cut by a cutter so that each spectrum in the cake is equally affected. The re-calculated cake is shown in Figure 4(c) together with

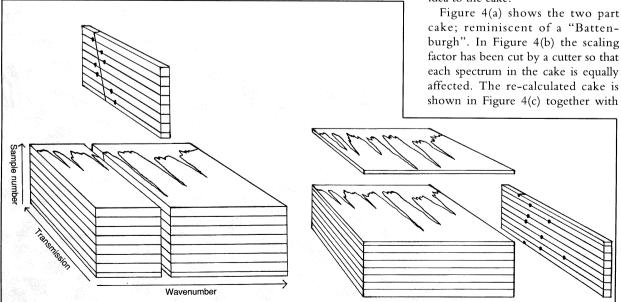


Figure 1. The data cake.

Figure 2. Computed slices from the data cake.

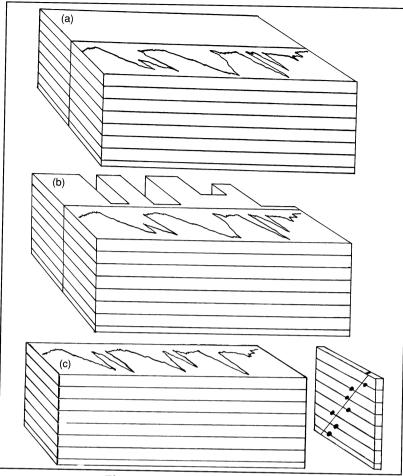


Figure 4. Cutting the scaled cake.

the new computed slice for the total transmission in the x direction. If we have been very clever with the choice of our cutter then these values might show a relationship with the sample number (or some other variable).

Now we come to the difficult part! We still have our cake (this is all happening in computer memory) and we can save this new computed slice, return to the original cake, select a new cutter and compute another new slice. I leave it to you to imagine forming new slices into a NEW data cake. Thus proving that you can have your cake and sample it!

Why do we want to do this? This may seem like a bit of fun with no real purpose. There is a purpose. Chemometrics has some very clever ways of choosing the data cutter, which are powerful tools for analysing complex data. In the next issue we shall meet one of them — factor analysis.

## Reference

1. S.W. Hawking, "A Brief History of a Brief History", *Popular Science (New York)* **235**, 70-72 (1989)

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